Investigation of LGAD performance dependence on neutron flux



Motivation



➢LGADs will at HL-LHC exposed to fluxes of particles around 10⁷-10⁸ cm² s⁻¹

➢Most of the irradiation studies done so far use fluxes which are much larger than that (typically ~10¹² cm² s⁻¹ at JSI reactor)

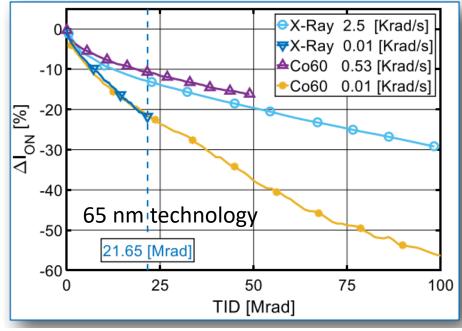
Dose rate effects observed in electronics and present a major problem (depends on bias/temperature/annealing) – safety factors

Question do we see that also in the bulk?

studies showed no flux effect on Neff/Ileak (D. Zontar et al.)

>effects to removal of initial dopants was not studied to our knowledge

 Possible dependence of initial acceptor removal rate would have a large implication to operation of LGADs at HL-LHC
positive in case of smaller removal at low rates
negative in case of larger removal at low rates



F. Faccio, HSTD11, Okinawa, 2017





The main channel for removal of initial acceptors is: Bs+I->Bi which is followed by reactions of Bi with other impurities and defects

Different mobilities of Vacancies (V) and Interstitials (I) can lead to different recombination rate of V-I if more are created close in space and time and don't have time to react with other impurties

Smaller recombination could effectively lead to larger removal at low fluxes 🛞

>As the mechanisms are not fully know a check is required.

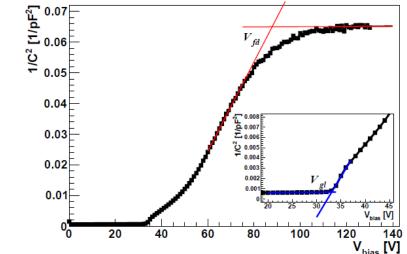




Samples used in the study

LGADs from ATLAS-HGTD prototype run with HPK were used – they different in implant dose and also in depth profile of the implant $\overline{\mathbb{T}}^{0.07}$

Sample name	Thickness	Vgl [V]	Vfd [V]
HPK-3.1-50	50 mm	42	49
НРК-3.2-50	50 mm	56	64



Samples were studied

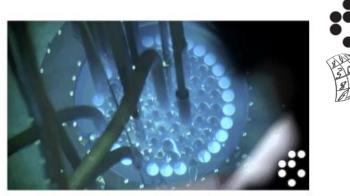
- > with CV/IV at 20oC and 10 kHz to determine Vgl, Vfd
- >Timing setup to verify that there is no impact to timing performance as well

All samples were annealed for 80min @ 60oC after irradiation to wipe out different history during irradiations

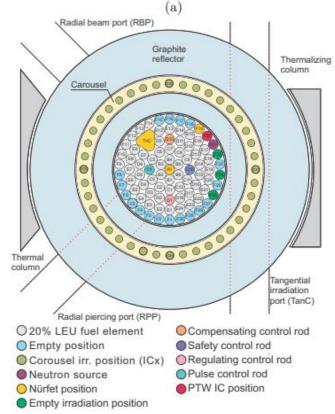


Irradiations

- Samples were irradiated with reactor neutrons at three different fluxes
 - 1.55e12 cm-2 s-1 (250 kW, F19 channel our standard irradiation flux)
 - ▶1.55e10 cm-2 s-1 (2.5 kW, F19 channel)
 - 7e12 cm-2 s-1 (250 kW, Central channel)
- >All samples were irradiated to the same fluence of 4e14 cm-2
 - Effects on Vgl are clearly visible
 - Timing measurement can be accurately performed
 - >A wide flux range can be practicaly studied
 - > 26000 s for slow (F19)
 - 260 s for standard (F19)
 - 57 s for fast (CK)



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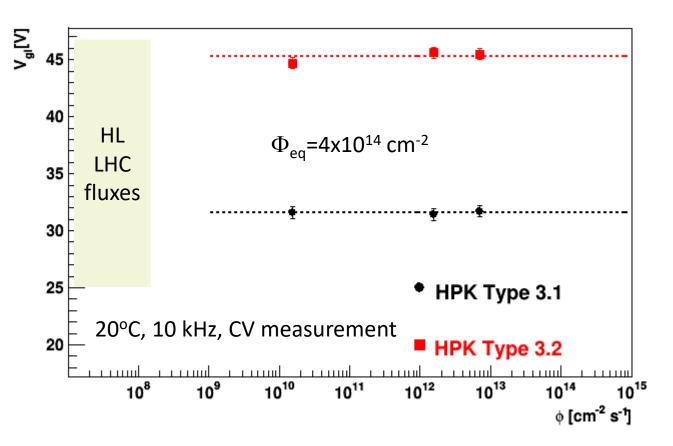




Measurements of gain layer depletion



> We are still two orders of magnitude away from HL-LHC fluxes, but the flux rate seem not to play a role on effective acceptor removal



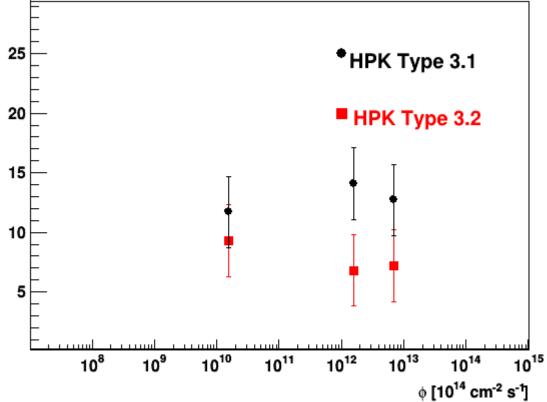
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Depletion of the bulk



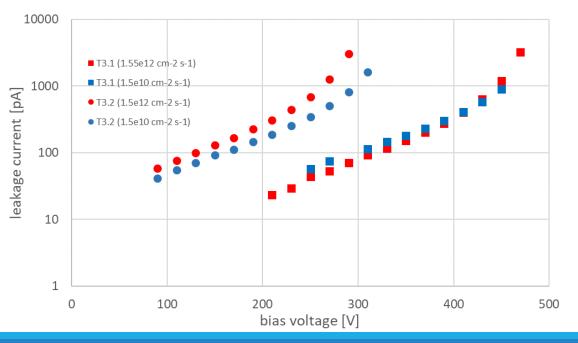
There is no flux impact on bulk depletion voltage for both investigated samples with different implant profiles
The result is in agreement with previous observations
More difficult to determine the Vfd (larger systematic error)
if full initial acceptor removal is assumed the gc=0.01-0.016 cm-1 which is compatible with standard introduction rate in FZ

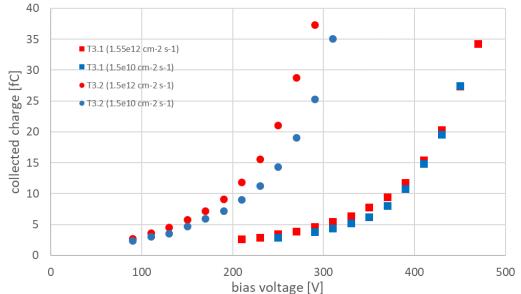


Charge and Timing measurements

At high voltages there may be effects not revealed by Vfd and Vgl measurements and may impact timing resolution and charge collection

CC and timing measurements are the ultimate benchmark, therefore all detectors were tested with Sr90 setup to very high bias voltages for performance







Conclusions and future work



➢In the investigated flux range of 10¹⁰ − 10¹³ cm⁻² s⁻¹ no flux dependence on the damage was found – gain layer and bulk

➤The gain and timing performance of all the sensors at high operation voltages was similar – no effects of different flux observed

➢This is still 2 orders of magnitude larger than rates at HL-LHC, but it is very probable that the flux effects are not present

➢Plans:

- > we can't irradiate for months, so it is not possible to go to much lower fluxes
- > We will go to high fluxes 10¹⁵-10¹⁶ cm⁻² s⁻¹ with reactor operating in pulse mode (above critical for very short amount of time) in the following months